Application/Control No. Applicant(s)/Patent Under Reexamination 10/010,761 ISHII ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Tadesse Hailu 2173 **U.S. PATENT DOCUMENTS** Document Number Date Country Code-Number-Kind Code Name Classification MM-YYYY US-5,353,391 Α 10-1994 Cohen et al. 345/619 * US-6,628,303 В 09-2003 Foreman et al. 715/723 * С US-6,686,970 02-2004 Windle, John Richard 348/584 D US-6,204,840 03-2001 Petelycky et al. 715/500.1 Ε US-F US-G US-US-Н 1 US-US-J US-Κ US-L М US-**FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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